

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10584790	MIYAKE ET AL.
	Examiner	Art Unit
	Lana N Le	2614

SEARCHED

Class	Subclass	Date	Examiner
455	150.1,180.1,307	9/02/09	LL

SEARCH NOTES

Search Notes	Date	Examiner

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

--	--